

SCES755C – DECEMBER 2009 – REVISED JULY 2012

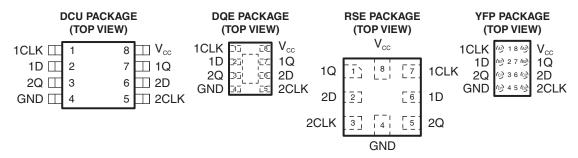
LOW-POWER DUAL POSITIVE EDGE-TRIGGERED D-TYPE FLIP-FLOP

Check for Samples: SN74AUP2G79

FEATURES

- Available in the Texas Instruments NanoStar™ Package
- Low Static-Power Consumption (I_{CC} = 0.9 μA Maximum)
- Low Dynamic-Power Consumption (C_{pd} = 3 pF Typ at 3.3 V)
- Low Input Capacitance (C_i = 1.5 pF Typical)
- Low Noise Overshoot and Undershoot <10% of V_{CC}
- Ioff Supports Partial-Power-Down Mode
 Operation
- Wide Operating V_{CC} Range of 0.8 V to 3.6 V

- Optimized for 3.3-V Operation
- 3.6-V I/O Tolerant to Support Mixed-Mode Signal Operation
- t_{pd} = 4 ns Maximum at 3.3 V
- Suitable for Point-to-Point Applications
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Performance Tested Per JESD 22
 - 2000-V Human-Body Model (A114-B, Class II)
 - 1000-V Charged-Device Model (C101)



See mechanical drawings for dimensions.

DESCRIPTION/ORDERING INFORMATION

The AUP family is TI's premier solution to the industry's low-power needs in battery-powered portable applications. This family ensures a very low static- and dynamic-power consumption across the entire V_{CC} range of 0.8 V to 3.6 V, resulting in increased battery life (see Figure 1). This product also maintains excellent signal integrity (see the very low undershoot and overshoot characteristics shown in Figure 2).

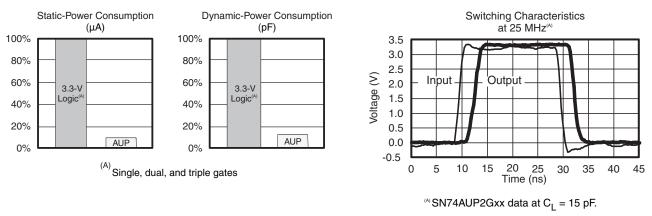


Figure 1. AUP – The Lowest-Power Family

Figure 2. Excellent Signal Integrity

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet. NanoStar is a trademark of Texas Instruments.

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When data at the data (D) input meets the setup time requirement, the data is transferred to the Q output on the positive-going edge of the clock pulse. Clock triggering occurs at a voltage level and is not directly related to the rise time of the clock pulse. Following the hold-time interval, data at the D input can be changed without affecting the levels at the outputs.

NanoStar[™] package technology is a major breakthrough in IC packaging concepts, using the die as the package.

This device is fully specified for partial-power-down applications using I_{off} . The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

ORDERING INFORMATION⁽¹⁾

	ONDE			
T _A	PACKAGE ⁽²⁾		ORDERABLE PART NUMBER	TOP-SIDE MARKING ⁽³⁾
	NanoStar™ – WCSP (DSBGA) 0.23-mm Large Bump – YFP (Pb-free)	Reel of 3000	SN74AUP2G79YFPR	H W _
–40°C to 85°C	uQFN – DQE	Reel of 5000	SN74AUP2G79DQER	PT
	QFN – RSE	Reel of 5000	SN74AUP2G79RSER	PT
	SSOP – DCU	Reel of 3000	SN74AUP2G79DCUR	H79_

(1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at www.ti.com.

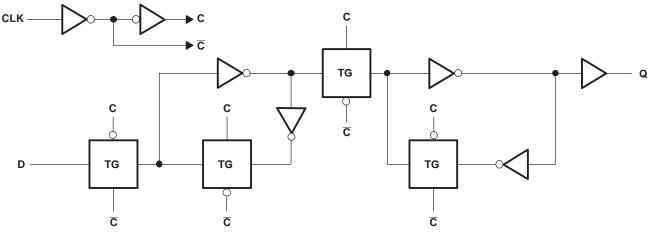
(2) Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.

(3) DCU: The actual top-side marking has one additional character that designates the wafer fab/assembly site. YFP: The actual top-side marking has three preceding characters to denote year, month, and sequence code, and one following

character to designate wafer fab/assembly site. Pin 1 identifier indicates solder-bump composition (1 = SnPb, • = Pb-free).

	FUNCTIC	IABLE
INPL	JTS	OUTPUT
CLK	D	Q
↑	н	н
↑	L	L
L	Х	Q ₀
Н	Х	Q ₀

LOGIC DIAGRAM, EACH FLIP-FLOP (POSITIVE LOGIC)



Pin numbers shown are for the DCU and DQE packages.



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ABSOLUTE MAXIMUM RATINGS⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V _{CC}	Supply voltage range		-0.5	4.6	V
VI	Input voltage range ⁽²⁾		-0.5	4.6	V
Vo	Voltage range applied to any output in the I	high-impedance or power-off state ⁽²⁾	-0.5	4.6	V
Vo	Output voltage range in the high or low stat	Output voltage range in the high or low state ⁽²⁾		V _{CC} + 0.5	V
I _{IK}	Input clamp current	V ₁ < 0		-50	mA
I _{OK}	Output clamp current	V ₀ < 0		-50	mA
I _O	Continuous output current			±20	mA
	Continuous current through V _{CC} or GND			±50	mA
		DCU package		220	
0	Declares the resulting a damag (3)	DQE package		261	0 0 / M
θ_{JA}	Package thermal impedance ⁽³⁾	RSE package		253	°C/W
		YFP package		132	
T _{stg}	Storage temperature range	·	-65	150	°C

Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating (1) conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed. The package thermal impedance is calculated in accordance with JESD 51-7. (2) (3)

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ISTRUMENTS

EXAS

RECOMMENDED OPERATING CONDITIONS⁽¹⁾

			MIN	MAX	UNIT	
V _{CC}	Supply voltage		0.8	3.6	V	
		$V_{CC} = 0.8 V$	V _{CC}			
V		V_{CC} = 1.1 V to 1.95 V	$0.65 \times V_{CC}$		V	
VIH	High-level input voltage	V_{CC} = 2.3 V to 2.7 V	1.6		V	
		V_{CC} = 3 V to 3.6 V	2			
		$V_{CC} = 0.8 V$		0		
V		V_{CC} = 1.1 V to 1.95 V		$0.35 \times V_{CC}$	V	
VIL	Low-level input voltage	V_{CC} = 2.3 V to 2.7 V		0.7	V	
		V_{CC} = 3 V to 3.6 V		0.9		
VI	Input voltage		0	3.6	V	
Vo	Output voltage		0	V _{CC}	V	
		$V_{CC} = 0.8 V$		-20	μA	
		$V_{CC} = 1.1 V$		-1.1		
	ab lovel output ourropt	$V_{CC} = 1.4 V$		-1.7	mA	
I _{OH}	High-level output current	V _{CC} = 1.65		-1.9		
		$V_{CC} = 2.3 V$		-3.1		
		$V_{CC} = 3 V$		-4		
		$V_{CC} = 0.8 V$		20	μA	
		V _{CC} = 1.1 V		1.1		
		$V_{CC} = 1.4 V$		1.7		
I _{OL}	Low-level output current	V _{CC} = 1.65 V		1.9 3.1		
		V _{CC} = 2.3 V				
		$V_{CC} = 3 V$		4		
Δt/Δv	Input transition rise or fall rate	$V_{CC} = 0.8 V \text{ to } 3.6 V$		200	ns/V	
T _A	Operating free-air temperature	·	-40	85	°C	

(1) All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

4 Submit Documentation Feedback

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ELECTRICAL CHARACTERISTICS

over recommended operating free-air temperature range (unless otherwise noted)

	TEST CONDITIONS	V	T _A	= 25°C	T _A = -40°C	to 85°C	
PARAMETER	TEST CONDITIONS	V _{cc}	MIN	TYP MAX	MIN	MAX	UNIT
	I _{OH} = -20 μA	0.8 V to 3.6 V	V _{CC} – 0.1		V _{CC} - 0.1		
	I _{OH} = -1.1 mA	1.1 V	0.75 × V _{CC}		$0.7 \times V_{CC}$		
	I _{OH} = -1.7 mA	1.4 V	1.11		1.03		
	I _{OH} = -1.9 mA	1.65 V	1.32		1.3		
V _{OH}	I _{OH} = -2.3 mA	2.2.1/	2.05		1.97		V
	I _{OH} = -3.1 mA	2.3 V	1.9		1.85		
	I _{OH} = -2.7 mA	0.14	2.72		2.67		
	$I_{OH} = -4 \text{ mA}$	3 V	2.6		2.55		
	I _{OL} = 20 μA	0.8 V to 3.6 V		0.1		0.1	V
	I _{OL} = 1.1 mA	1.1 V		$0.3 \times V_{CC}$		$0.3 \times V_{CC}$	
	I _{OL} = 1.7 mA	1.4 V		0.31		0.37	
	I _{OL} = 1.9 mA	1.65 V		0.31		0.35	
V _{OL}	I _{OL} = 2.3 mA	2.2.1/		0.31		0.33	
	I _{OL} = 3.1 mA	2.3 V		0.44		0.45	
	I _{OL} = 2.7 mA	3 V		0.31		0.33	
	$I_{OL} = 4 \text{ mA}$	3 V		0.44		0.45	
A or B input	$V_I = GND$ to 3.6 V	0 V to 3.6 V		0.1		0.5	μA
off	V_{I} or V_{O} = 0 V to 3.6 V	0 V		0.2		0.6	μA
∆I _{off}	V_{I} or V_{O} = 0 V to 3.6 V	0 V to 0.2 V		0.2		0.6	μA
lcc		0.8 V to 3.6 V		0.5		0.9	μA
ΔI _{CC}	$V_{I} = V_{CC} - 0.6 V^{(1)},$ $I_{O} = 0$	3.3 V		40		50	μA
0		0 V		1.5			~ ۲
Ci	$V_I = V_{CC}$ or GND	3.6 V		1.5			pF
C _o	$V_{O} = GND$	0 V		3			pF

(1) One input at V_{CC} – 0.6 V, other input at V_{CC} or GND

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TIMING REQUIREMENTS

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 4)

			V _{cc}	T _A = 25°C	T _A = -40°C to 85°C	UNIT
				TYP	MIN MAX	
			0.8 V		20	
			1.2 V ± 0.1 V		80	
¢.			1.5 V ± 0.1 V		100	N 41 1-
f _{clock}	Clock frequency		1.8 V ± 0.15 V		140	MHz
			2.5 V ± 0.2 V		210	
			3.3 V ± 0.3 V		260	
			0.8 V		4.8	
			1.2 V ± 0.1 V		2.2	
L	Dulas duration CLK high or low		1.5 V ± 0.1 V		1.5	
t _w	Pulse duration, CLK high or low		1.8 V ± 0.15 V		1.6	ns
			2.5 V ± 0.2 V		1.7	
			3.3 V ± 0.3 V		1.9	
			0.8 V	2.9	4.2	ns
			1.2 V ± 0.1 V		1.4	
		Data bish	1.5 V ± 0.1 V		1	
		Data high	1.8 V ± 0.15 V		0.9	
			2.5 V ± 0.2 V		0.7	
			3.3 V ± 0.3 V		0.6	
su	Setup time before CLK↑		0.8 V	3.5	5.3	
			1.2 V ± 0.1 V		1.8	
		Data law	1.5 V ± 0.1 V		1.2	+
		Data low	1.8 V ± 0.15 V		1.1	
			2.5 V ± 0.2 V		1	
			3.3 V ± 0.3 V		1	
			0.8 V	0	0	
			1.2 V ± 0.1 V		0	
	Held time, data after CLIVA		1.5 V ± 0.1 V		0	
ĥ	Hold time, data after CLK↑		1.8 V ± 0.15 V		0	ns
			2.5 V ± 0.2 V		0	
			3.3 V ± 0.3 V		0	



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SWITCHING CHARACTERISTICS

over recommended operating free-air temperature range, $C_L = 5 \text{ pF}$ (unless otherwise noted) (see Figure 3 and Figure 4)

PARAMETER		TO (OUTPUT)	V _{cc}	T _A = 25°C			T _A = -40°C to 85°C		UNIT
		(001901)		MIN	TYP	MAX	MIN	MAX	
			0.8 V		93		90		
			1.2 V ± 0.1 V		199		220		
4			1.5 V ± 0.1 V		250		230		N 41 1-
f _{max}			1.8 V ± 0.15 V		271		240		MHz
			2.5 V ± 0.2 V		280		250		
			3.3 V ± 0.3 V		280		260		
			0.8 V		15.9				
			1.2 V ± 0.1 V	3.7	6.9	11	2.6	13.1	
		0	1.5 V ± 0.1 V	3	4.8	7.6	2	8.8	
t _{pd}	CLK	Q	1.8 V ± 0.15 V	2.4	3.8	6.1	1.5	7.1	ns
			2.5 V ± 0.2 V	1.8	2.7	4.4	1.1	5	
			3.3 V ± 0.3 V	1.5	2.1	3.6	0.9	4	

SWITCHING CHARACTERISTICS

over recommended operating free-air temperature range, $C_L = 10 \text{ pF}$ (unless otherwise noted) (see Figure 3 and Figure 4)

PARAMETER	FROM (INPUT)	- Vee	Vcc	T _A = 25°C			T _A = −40°C to 85°C		UNIT
				(001701)		MIN	TYP	MAX	MIN
			0.8 V		62		50		
f _{max}			1.2 V ± 0.1 V		147		160		
			1.5 V ± 0.1 V		189		200		N411-
			1.8 V ± 0.15 V		180		240		MHz
			2.5 V ± 0.2 V		260		250		
			3.3 V ± 0.3 V		280		260		
			0.8 V		18				
			1.2 V ± 0.1 V	4.3	7.8	12.3	3.2	14.4	
		0	1.5 V ± 0.1 V	3.5	5.5	8.4	2.5	9.8	20
t _{pd}	CLK	Q	1.8 V ± 0.15 V	2.8	4.4	6.8	1.9	8	ns
			2.5 V ± 0.2 V	2.2	3.2	5	1.5	5.7	
			3.3 V ± 0.3 V	1.8	2.6	4.1	1.3	4.5	



SWITCHING CHARACTERISTICS

over recommended operating free-air temperature range, $C_L = 15 \text{ pF}$ (unless otherwise noted) (see Figure 3 and Figure 4)

PARAMETER	FROM	TO (OUTPUT)	V _{cc}	Τ ₄	∖ = 25°C		T _A = to 85		UNIT
	(INPUT)			MIN	TYP	MAX	MIN	MAX	
f _{max}			0.8 V		48		30		
			1.2 V ± 0.1 V		112		120		
			1.5 V ± 0.1 V		151		160		MHz
			1.8 V ± 0.15 V		194		220		IVIEZ
			2.5 V ± 0.2 V		248		250		
			$3.3 \text{ V} \pm 0.3 \text{ V}$		280		260		
			0.8 V		20.3				
			1.2 V ± 0.1 V	5	8.7	13.6	3.9	15.6	
+		0	1.5 V ± 0.1 V	4.1	6.3	9.3	3.1	10.7	20
t _{pd}	ULK	CLK Q	1.8 V ± 0.15 V	3.3	4	7.6	2.4	8.7	ns
			$2.5 \text{ V} \pm 0.2 \text{ V}$	2.6	3.6	5.5	1.9	6.3	
			$3.3 \text{ V} \pm 0.3 \text{ V}$	2.2	3	4.5	1.6	5	

SWITCHING CHARACTERISTICS

over recommended operating free-air temperature range, $C_L = 30 \text{ pF}$ (unless otherwise noted) (see Figure 3 and Figure 4)

PARAMETER	FROM	TO (OUTPUT) V _{CC}	T _A = 25°C			T _A = −40°C to 85°C		UNIT	
	(INPUT)	(001901)		MIN	N TYP	MAX	MIN	MAX	
			0.8 V		24		20		
f _{max}			1.2 V ± 0.1 V		72		80		
			1.5 V ± 0.1 V		100		100		N41 1-
			1.8 V ± 0.15 V		127		140		MHz
			2.5 V ± 0.2 V		185		210		
			3.3 V ± 0.3 V		266		260		
			0.8 V		27.2				
			1.2 V ± 0.1 V	7	11.5	17.3	5.9	24	
	CL K	0	1.5 V ± 0.1 V	5.7	8.3	13.3	4.6	15.9	20
t _{pd}	CLK	Q	1.8 V ± 0.15 V	4.7	6.7	11.3	3.8	13	ns
			2.5 V ± 0.2 V	3.7	4.9	7.8	2.9	9	
			3.3 V ± 0.3 V	3.2	4.1	6.3	2.6	7.2	

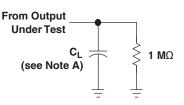
OPERATING CHARACTERISTICS

 $T_A = 25^{\circ}C$

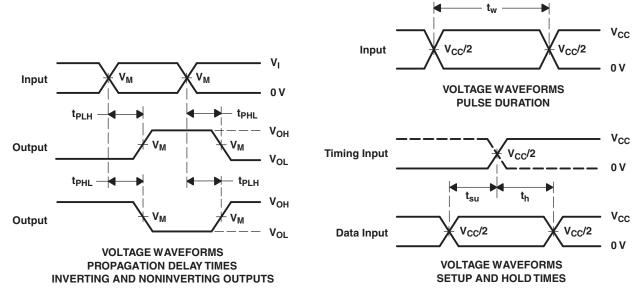
	PARAMETER	TEST CONDITIONS	V _{cc}	TYP	UNIT
			0.8 V	2.5	
			1.2 V ± 0.1 V	2.5	pF
<u> </u>	Dower dissinction conscitutes		1.5 V ± 0.1 V	2.5	
C _{pd}	Power dissipation capacitance	f = 10 MHz	1.8 V ± 0.15 V	2.5	
			2.5 V ± 0.2 V	3	
			3.3 V ± 0.3 V	3	



PARAMETER MEASUREMENT INFORMATION (Propagation Delays, Setup and Hold Times, and Pulse Width)



	V _{CC} = 0.8 V	$V_{CC} = 1.2 V$ $\pm 0.1 V$	$V_{CC} = 1.5 V$ ± 0.1 V	$V_{CC} = 1.8 V$ $\pm 0.15 V$	V_{CC} = 2.5 V ± 0.2 V	$V_{CC} = 3.3 V$ ± 0.3 V
CL	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF
V _M	V _{CC} /2	V _{CC} /2	V _{CC} /2	V _{CC} /2	V _{CC} /2	V _{CC} /2
VI	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}



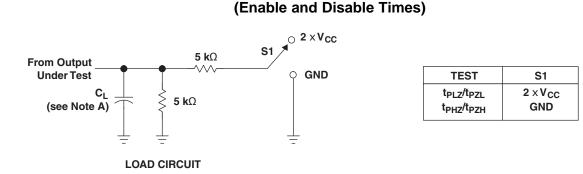
- C₁ includes probe and jig capacitance. Α.
- В. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z₀ = 50 Ω , for propagation delays $t_r/t_f = 3$ ns, for setup and hold times and pulse width $t_r/t_f = 1.2$ ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- t_{PLH} and t_{PHL} are the same as t_{pd} . Ε.
- F. All parameters and waveforms are not applicable to all devices.

Figure 3. Load Circuit and Voltage Waveforms

LOAD CIRCUIT

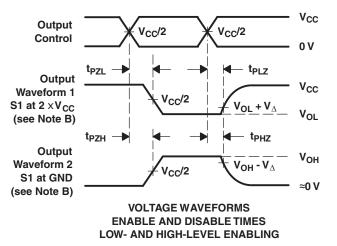


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PARAMETER MEASUREMENT INFORMATION

	V _{CC} = 0.8 V	$V_{\rm CC} = 0.8 {\rm V}$ $V_{\rm CC} = 1.2 {\rm V}$ $\pm 0.1 {\rm V}$		V_{CC} = 1.8 V ± 0.15 V	V_{CC} = 2.5 V \pm 0.2 V	V_{CC} = 3.3 V \pm 0.3 V
С _L	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF
V _M	V _{CC} /2	V _{CC} /2	V _{CC} /2	V _{CC} /2	V _{CC} /2	V _{CC} /2
V _I	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}
V _Δ	0.1 V	0.1 V	0.1 V	0.15 V	0.15 V	0.3 V



- A. C_L includes probe and jig capacitance.
- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z₀ = 50 Ω , t_r/t_f = 3 ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E. t_{PLZ} and t_{PHZ} are the same as t_{dis}.
- F. t_{PLH} and t_{PHL} are the same as t_{pd} .
- G. All parameters and waveforms are not applicable to all devices.

Figure 4. Load Circuit and Voltage Waveforms

TEXAS INSTRUMENTS

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REVISION HISTORY

Ch	hanges from Revision B (March 2010) to Revision C					
•	Added clock high to FUNCTION TABLE.		2			



PACKAGING INFORMATION

Orderable Device		Package Type	Package Drawing	Pins	Package Qty		Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		uly	(2)	(6)	(3)		(4/5)	
SN74AUP2G79DCUR	ACTIVE	VSSOP	DCU	8	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	H79R	Samples
SN74AUP2G79DQER	ACTIVE	X2SON	DQE	8	5000	RoHS & Green	NIPDAUAG	Level-1-260C-UNLIM	-40 to 85	PT	Samples
SN74AUP2G79RSER	ACTIVE	UQFN	RSE	8	5000	RoHS & Green	NIPDAUAG	Level-1-260C-UNLIM	-40 to 85	PT	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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Texas

STRUMENTS

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74AUP2G79DCUR	VSSOP	DCU	8	3000	180.0	8.4	2.25	3.35	1.05	4.0	8.0	Q3
SN74AUP2G79DQER	X2SON	DQE	8	5000	180.0	8.4	1.2	1.6	0.55	4.0	8.0	Q1
SN74AUP2G79RSER	UQFN	RSE	8	5000	180.0	8.4	1.7	1.7	0.7	4.0	8.0	Q2



PACKAGE MATERIALS INFORMATION

3-Nov-2023



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74AUP2G79DCUR	VSSOP	DCU	8	3000	202.0	201.0	28.0
SN74AUP2G79DQER	X2SON	DQE	8	5000	202.0	201.0	28.0
SN74AUP2G79RSER	UQFN	RSE	8	5000	202.0	201.0	28.0

DCU0008A



PACKAGE OUTLINE

VSSOP - 0.9 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side. 4. Reference JEDEC registration MO-187 variation CA.



DCU0008A

EXAMPLE BOARD LAYOUT

VSSOP - 0.9 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

5. Publication IPC-7351 may have alternate designs.

6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



DCU0008A

EXAMPLE STENCIL DESIGN

VSSOP - 0.9 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

8. Board assembly site may have different recommendations for stencil design.



^{7.} Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

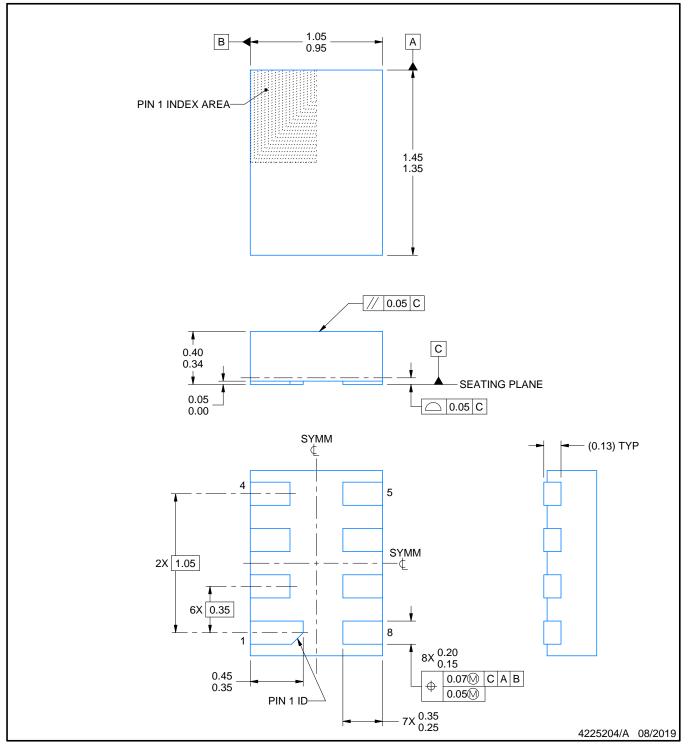
DQE0008A



PACKAGE OUTLINE

X2SON - 0.4 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
 This drawing is subject to change without notice.
 This package complies to JEDEC MO-287 variation X2EAF.

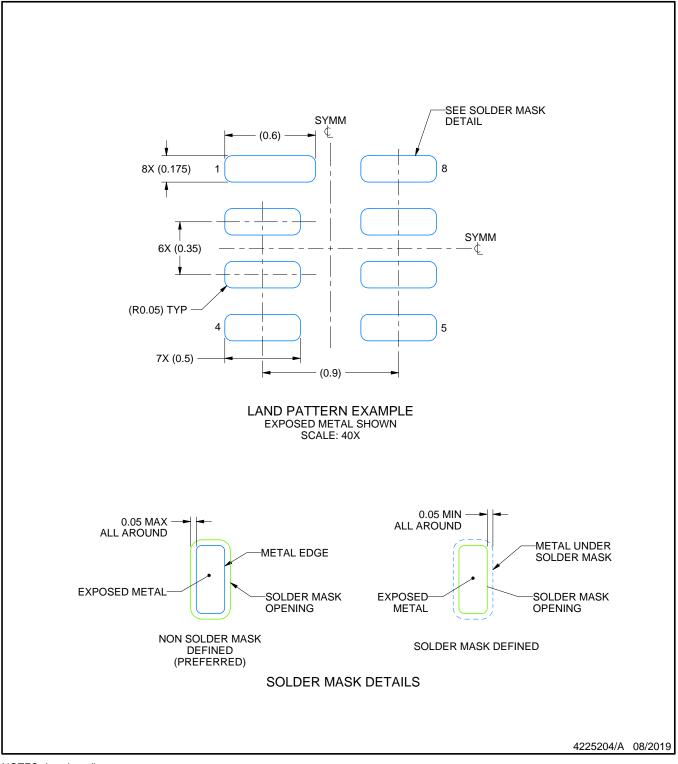


DQE0008A

EXAMPLE BOARD LAYOUT

X2SON - 0.4 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

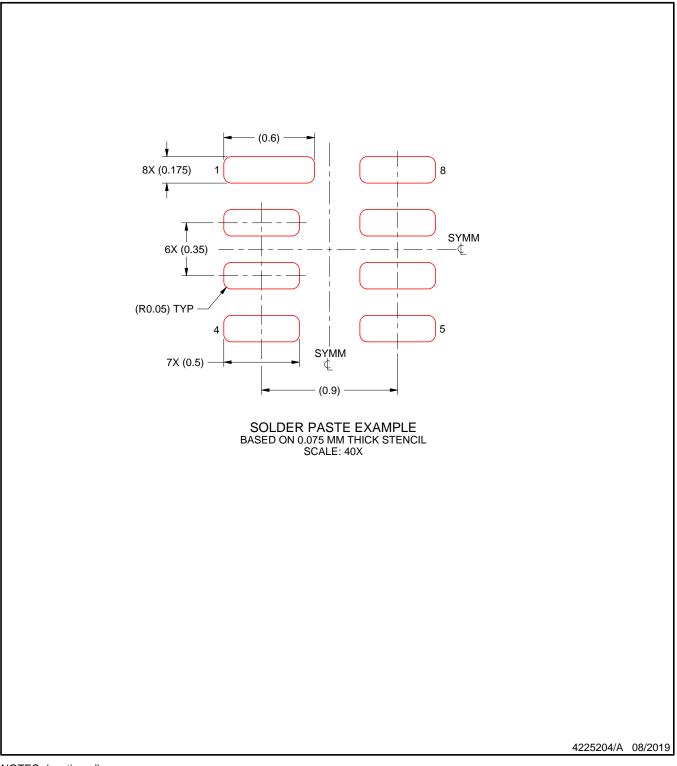


DQE0008A

EXAMPLE STENCIL DESIGN

X2SON - 0.4 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



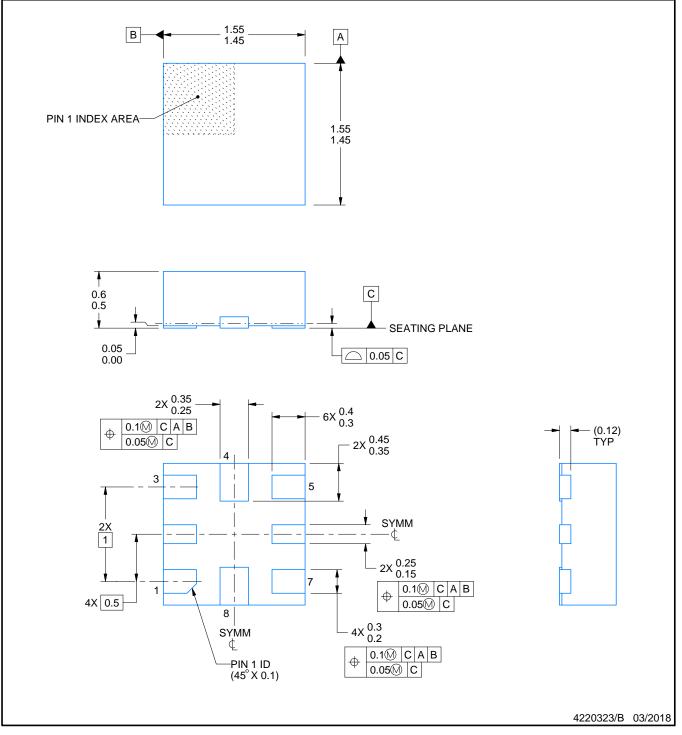
RSE0008A



PACKAGE OUTLINE

UQFN - 0.6 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.

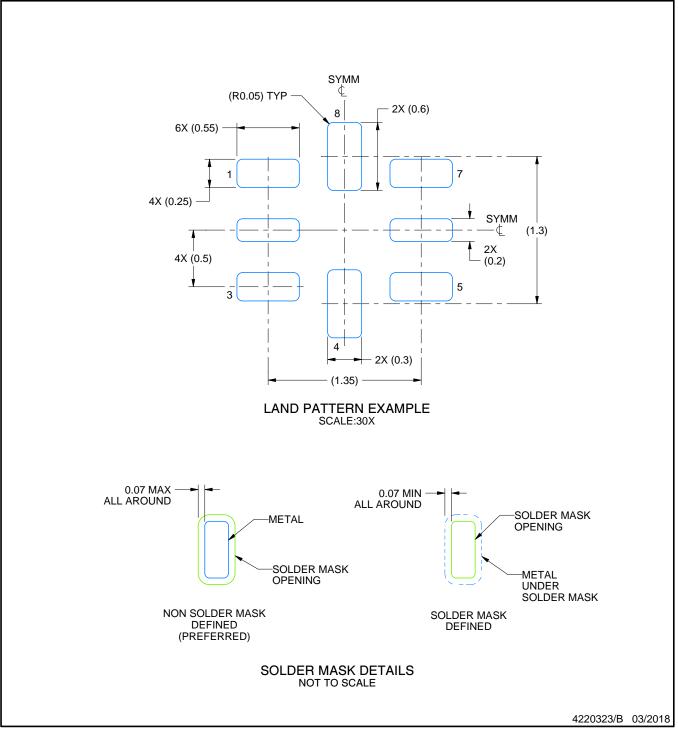


RSE0008A

EXAMPLE BOARD LAYOUT

UQFN - 0.6 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

3. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

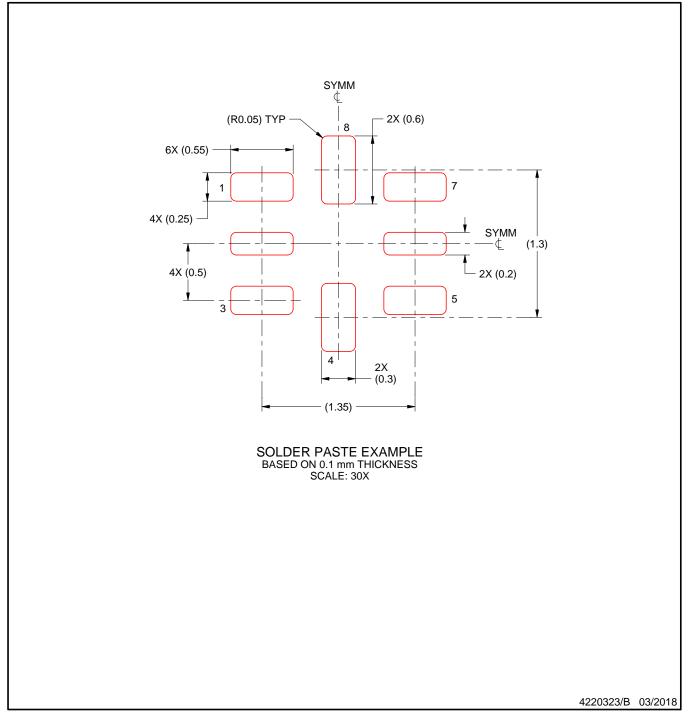


RSE0008A

EXAMPLE STENCIL DESIGN

UQFN - 0.6 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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